



256K × 8 CMOS FLASH MEMORY

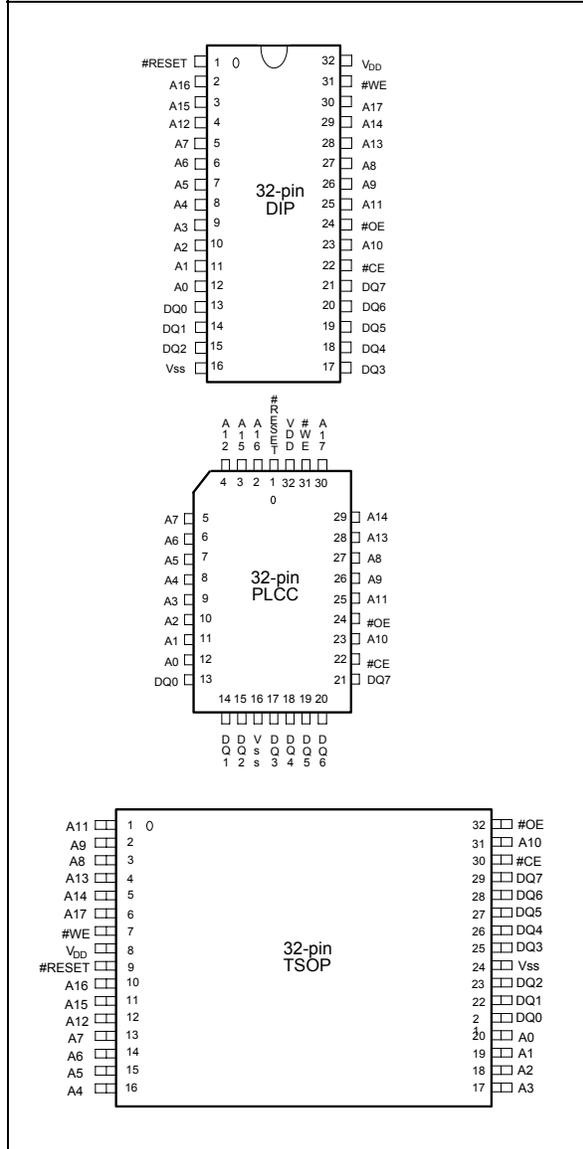
1. GENERAL DESCRIPTION

The W49F020 is a 2-megabit, 5-volt only CMOS flash memory organized as 256K × 8 bits. The device can be programmed and erased in-system with a standard 5V power supply. A 12-volt VPP is not required. The unique cell architecture of the W49F020 results in fast program/erase operations with extremely low current consumption (compared to other comparable 5-volt flash memory products). The device can also be programmed and erased using standard EPROM programmers.

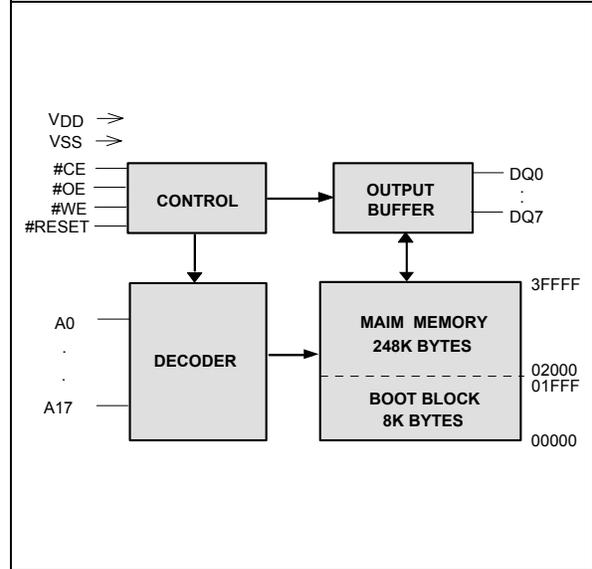
2. FEATURES

- Single 5-volt operations:
 - 5-volt read
 - 5-volt erase
 - 5-volt program
- Fast Program operation:
 - Byte-by-Byte programming: 50 μS (max.)
- Fast erase operation: 100 mS (typ.)
- Fast read access time: 70/90 nS
- Endurance: 10K cycles (typ.)
- Twenty-year data retention
- Hardware data protection
- One 8K Byte boot block with lockout protection
- Low power consumption
 - Active current: 25 mA (typ.)
 - Standby current: 20 μA (typ.)
- Automatic program and erase timing with internal VPP generation
- End of program or erase detection
 - Toggle bit
 - Data polling
- Latched address and data
- TTL compatible I/O
- JEDEC standard byte-wide pinouts
- Available packages: 32-pin DIP and 32-pin TSOP and 32-pin-PLCC

3. PIN CONFIGURATIONS



4. BLOCK DIAGRAM



5. PIN DESCRIPTION

SYMBOL	PIN NAME
A0 – A17	Address Inputs
DQ0 – DQ7	Data Inputs/Outputs
#CE	Chip Enable
#OE	Output Enable
#WE	Write Enable
#RESET	Reset
VDD	Power Supply
Vss	Ground
NC	No Connection



6. FUNCTIONAL DESCRIPTION

Read Mode

The read operation of the W49F020 is controlled by #CE and #OE, both of which have to be low for the host to obtain data from the outputs. #CE is used for device selection. When #CE is high, the chip is de-selected and only standby power will be consumed. #OE is the output control and is used to gate data from the output pins. The data bus is in high impedance state when either #CE or #OE is high. Refer to the timing waveforms for further details.

Reset Operation

The #RESET pin provides a hardware method of resetting the device to reading array data. When the system drives the #RESET pin low for at least a period of t_{RSTP} , the device immediately terminates any operation in progress and ignores all attempts for the duration of the #RESET pulse. The device also resets the internal state machine to reading array data. The operation that was interrupted should be reinitiated once the device is ready to accept another command sequence, to ensure data integrity.

Current is reduced for the duration of the #RESET pulse. When #RESET is held at V_{IL} , the device enters the TTL standby mode; if #RESET is held at V_{SS} , the device enters the CMOS standby mode.

The #RESET pin may be tied to the system reset circuitry. A system reset would thus also reset the Flash memory, enabling the system to read the boot-up firmware from the Flash memory.

Boot Block Operation

There is an 8K-byte boot block in this device, which can be used to store boot code. The boot block locates in the first 8K bytes of the memory with the address range from 0000(hex) to 1FFF(hex). For the specific code, please see Command Codes for Boot Block Lockout Enable.

When the boot block is enabled, data for the designated block cannot be erased or programmed (programming lockout); other memory locations can be changed by the regular programming method. When the boot block programming lockout feature is activated, the chip erase function cannot erase the boot block any longer.

In order to detect whether the boot block feature is set on the 8K-bytes block or not, users can perform software command sequence to check it. First, enter the product identification mode (see Command Codes for Identification/Boot Block Lockout Detection for specific code), and then read from address "0002 hex". If the output data is "1," the boot block programming lockout feature is activated; if the output data is "0," the lockout feature is inactivated and the block can be erased/programmed.

To return to normal operation, perform a three-byte command sequence (or an alternate single-word command) to exit the identification mode. For the specific code, see Command Codes for Identification/Boot Block Lockout Detection.

Chip Erase Operation

The chip-erase mode can be initiated by a six-word command sequence. After the command loading cycle, the device enters the internal chip erase mode, which is automatically timed and will be completed in a fast 100 mS (typical). The host system is not required to provide any control or timing during this operation. If the boot block programming lockout is activated, only the data in the main memory blocks will be erased to FF(hex), and the data in the boot block will not be erased (remains same as before the chip erase operation). The entire memory array will be erased to FF hex by the chip erase operation if the boot block programming lockout feature is not activated. Once the boot block lockout feature is activated, the chip erase function erase the main memory block but not the boot block. The device will



automatically return to normal read mode after the erase operation completed. Data polling and/or Toggle Bits can be used to detect end of erase cycle.

Program Operation

The W49F020 is programmed on a byte-by-byte basis. Program operation can only change logical data "1" to logical data "0." The erase operation (changed entire data in main memory blocks and/or boot block from "0" to "1") is needed before programming.

The program operation is initiated by a 4-word command cycle (see Command Codes for Byte Programming). The device will internally enter the program operation immediately after the byte-program command is entered. The internal program timer will automatically time-out (50 μ S max. - TBP) when completing programming and return to normal read mode. Data polling and/or Toggle Bits can be used to detect end of program cycle.

Hardware Data Protection

The integrity of the data stored in the W49F020 is also hardware protected in the following ways:

- (1) Noise/Glitch Protection: A #WE pulse with less than 15 nS in duration will not initiate a write cycle.
- (2) VDD Power Up/Down Detection: The programming and read operation are inhibited when VDD is less than 2.5V typical.
- (3) Write Inhibit Mode: Forcing #OE low, #CE high, or #WE high will inhibit the write operation. This prevents inadvertent writes during power-up or power-down periods.
- (4) VDD power-on delay: When VDD has reached its sense level, the device will automatically time-out 5 mS before any write (erase/program) operation.

Data Polling (DQ7)- Write Status Detection

The W49F020 features a data polling function which used to indicate the end of a program or erase cycle. When the W49F020 is in the internal program or erase cycle, any attempt to read DQ7 of the last word loaded will receive the complement of the true data. Once the program or erase cycle is completed, DQ7 will show the true data. Note that DQ7 will show logical "0" during the erase cycle, and become logical "1" or true data when the erase cycle has been completed.

Toggle Bit (DQ6)- Write Status Detection

In addition to data polling, the W49F020 provides another method for determining the end of a program cycle. During the internal program or erase cycle, any consecutive attempts to read DQ6 will produce alternating 0's and 1's. When the program or erase cycle is completed, this toggling between 0's and 1's will stop. The device is then ready for the next operation.

Product Identification

The product ID operation outputs the manufacturer code and device code. Programming equipment automatically matches the device with its proper erase and programming algorithms.

The manufacturer and device codes can be accessed by software or hardware operation. In software access mode, a three-word (or JEDEC 3-word) command sequence can be used to access the product ID. A read from address 0000H outputs the manufacturer code DA(hex); and a read from address 0001H outputs the device code 8C(hex) for W49F020. The product ID operation can be terminated by a three-word command sequence or an alternated one-word command sequence (see Command Definition table).



In the hardware access mode, access to the product ID will be activated by forcing #CE and #OE low, #WE high, and raising A9 to 12 volts.

Table of Operating Modes

Operating Mode Selection

(V_{HH} = 12V ± 5%)

MODE	PINS					
	#CE	#OE	#WE	#RESET	ADDRESS	DQ0-DQ7
Read	VIL	VIL	VIH	VIH	A _{IN}	D _{out}
Write	VIL	VIH	VIL	VIH	A _{IN}	D _{in}
Standby	VIH	X	X	VIH	X	High Z
Write Inhibit	X	VIL	X	X	X	High Z/DOUT
	X	X	VIH	VIH	X	High Z/DOUT
Output Disable	X	VIH	X	VIH	X	High Z
Reset	X	X	X	VIL	X	High Z
Product ID	VIL	VIL	VIH	VIH	A0 = VIL; A1 – A17 = VIL; A9 = V _{HH}	Manufacturer Code DA (Hex)
	VIL	VIL	VIH	VIH	A0 = VIL; A1 – A17 = VIL; A9 = V _{HH}	Device Code 8C (Hex)

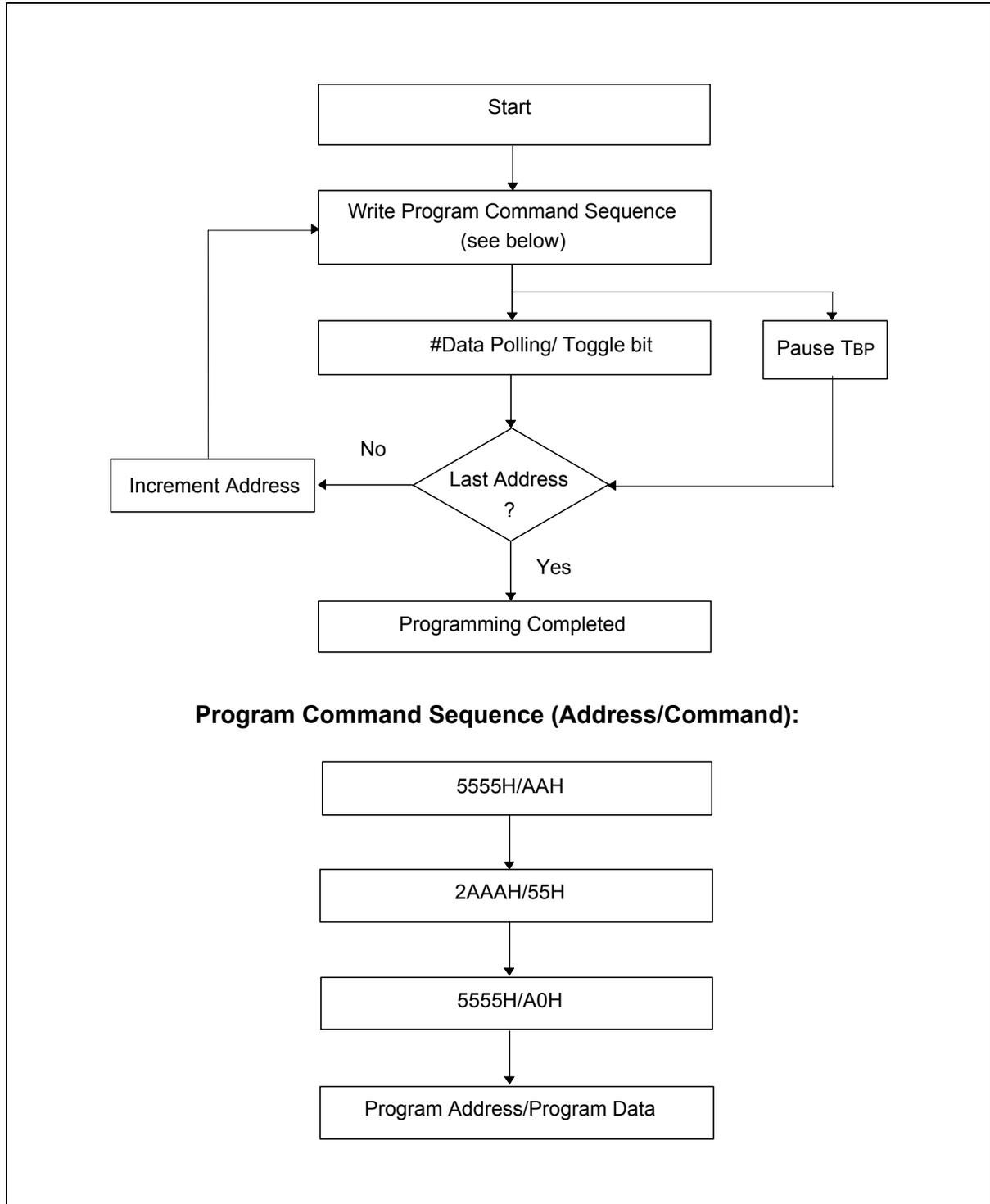
Table of Command Definition

COMMAND DESCRIPTION	NO. OF Cycles	1ST CYCLE	2ND CYCLE	3RD CYCLE	4TH CYCLE	5TH CYCLE	6TH CYCLE
		Addr. Data	Addr. Data	Addr. Data	Addr. Data	Addr. Data	Addr. Data
Read	1	A _{IN} D _{OUT}					
Chip Erase	6	5555 AA	2AAA 55	5555 80	5555 AA	2AAA 55	5555 10
Byte Program	4	5555 AA	2AAA 55	5555 A0	A _{IN} D _{IN}		
Boot Block Lockout	6	5555 AA	2AAA 55	5555 80	5555 AA	2AAA 55	5555 40
Product ID Entry	3	5555 AA	2AAA 55	5555 90			
Product ID Exit ⁽¹⁾	3	5555 AA	2AAA 55	5555 F0			
Product ID Exit ⁽¹⁾	1	XXXX F0					

Notes:

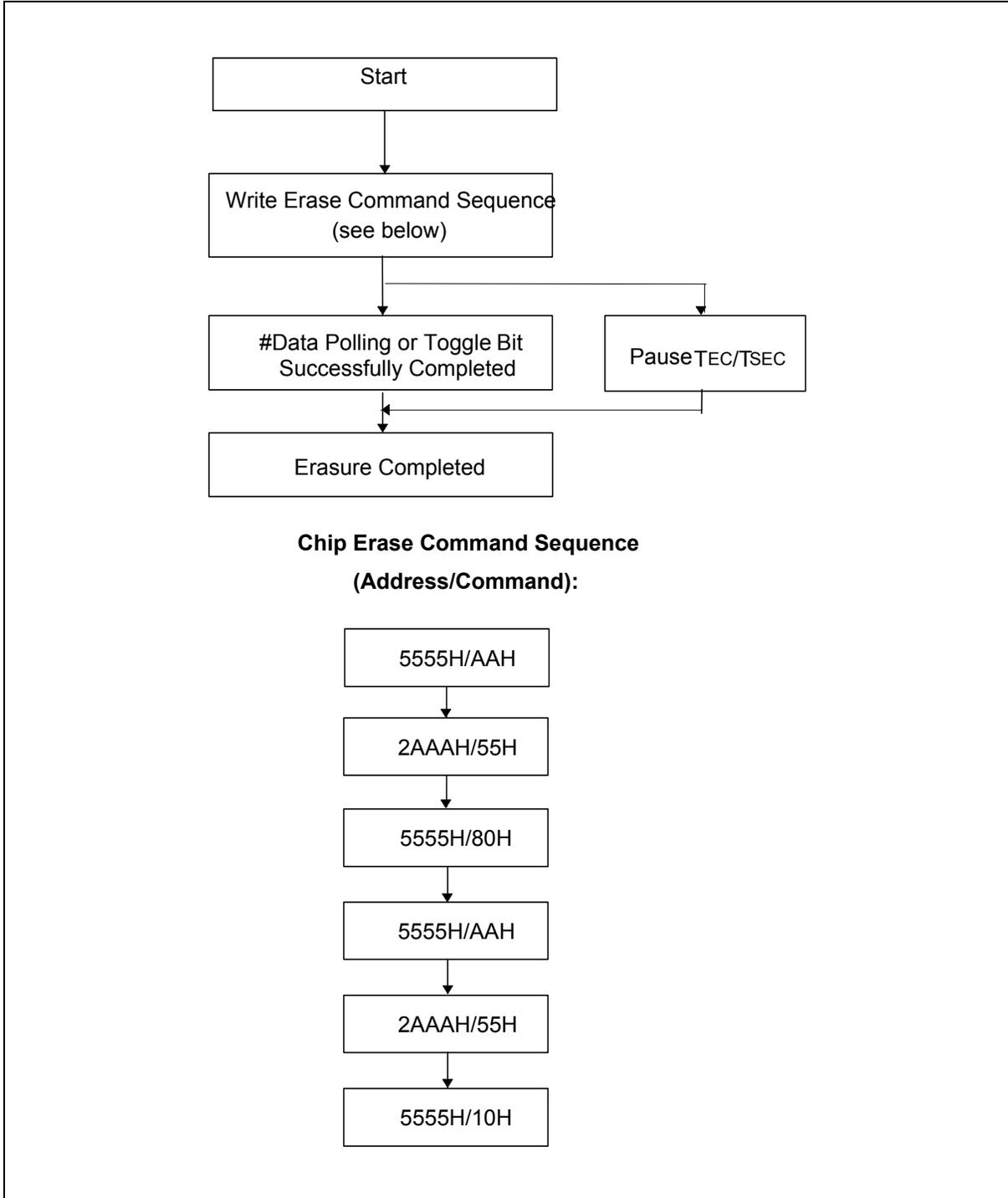
1. Address Format: A14 – A0 (Hex); Data Format: DQ7 – DQ0 (Hex)
2. Either one of the two Product ID Exit commands can be used.

Embedded Programming Algorithm



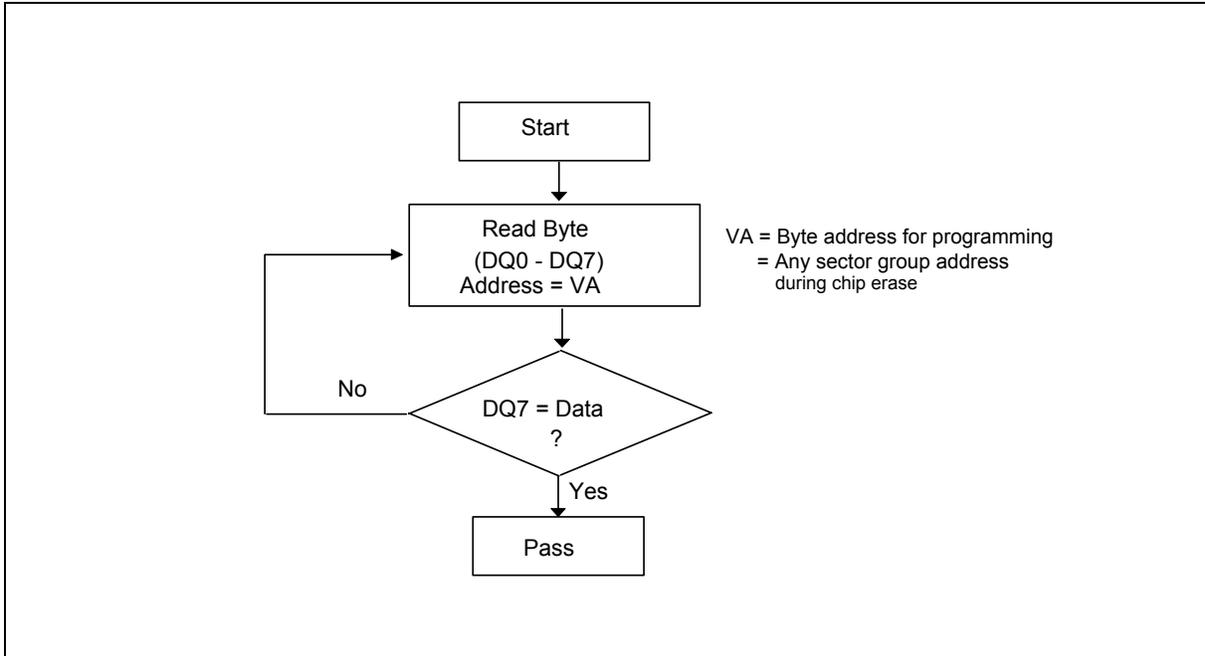


Embedded Erase Algorithm

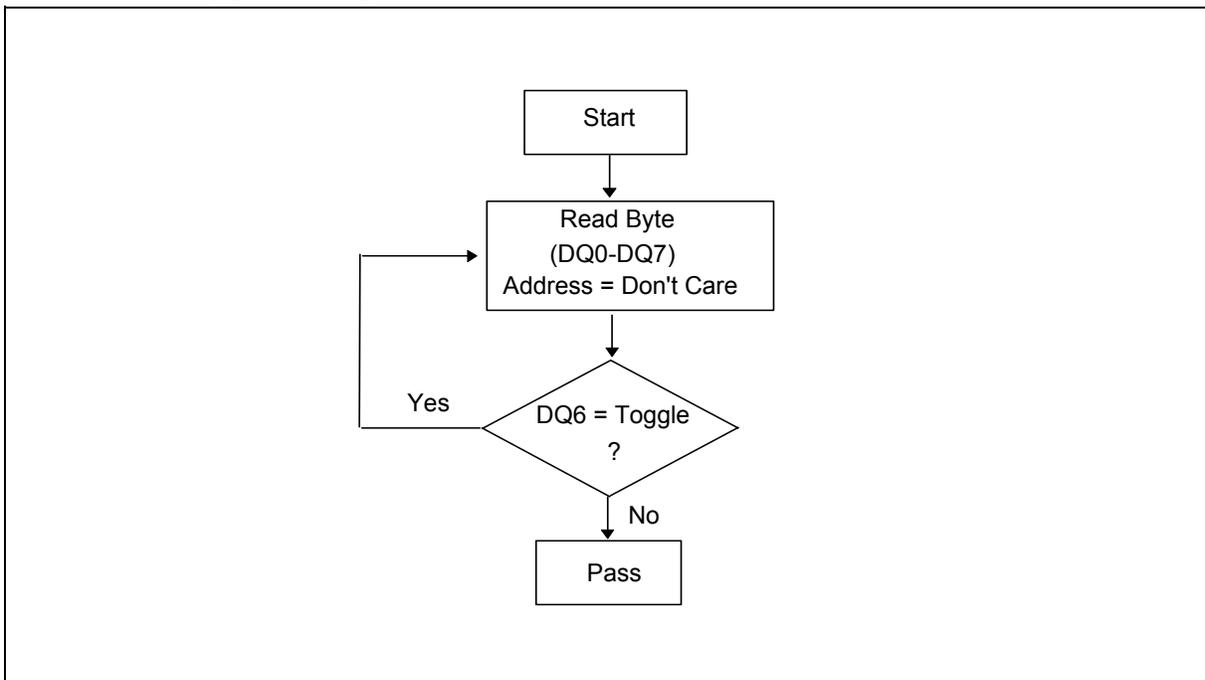




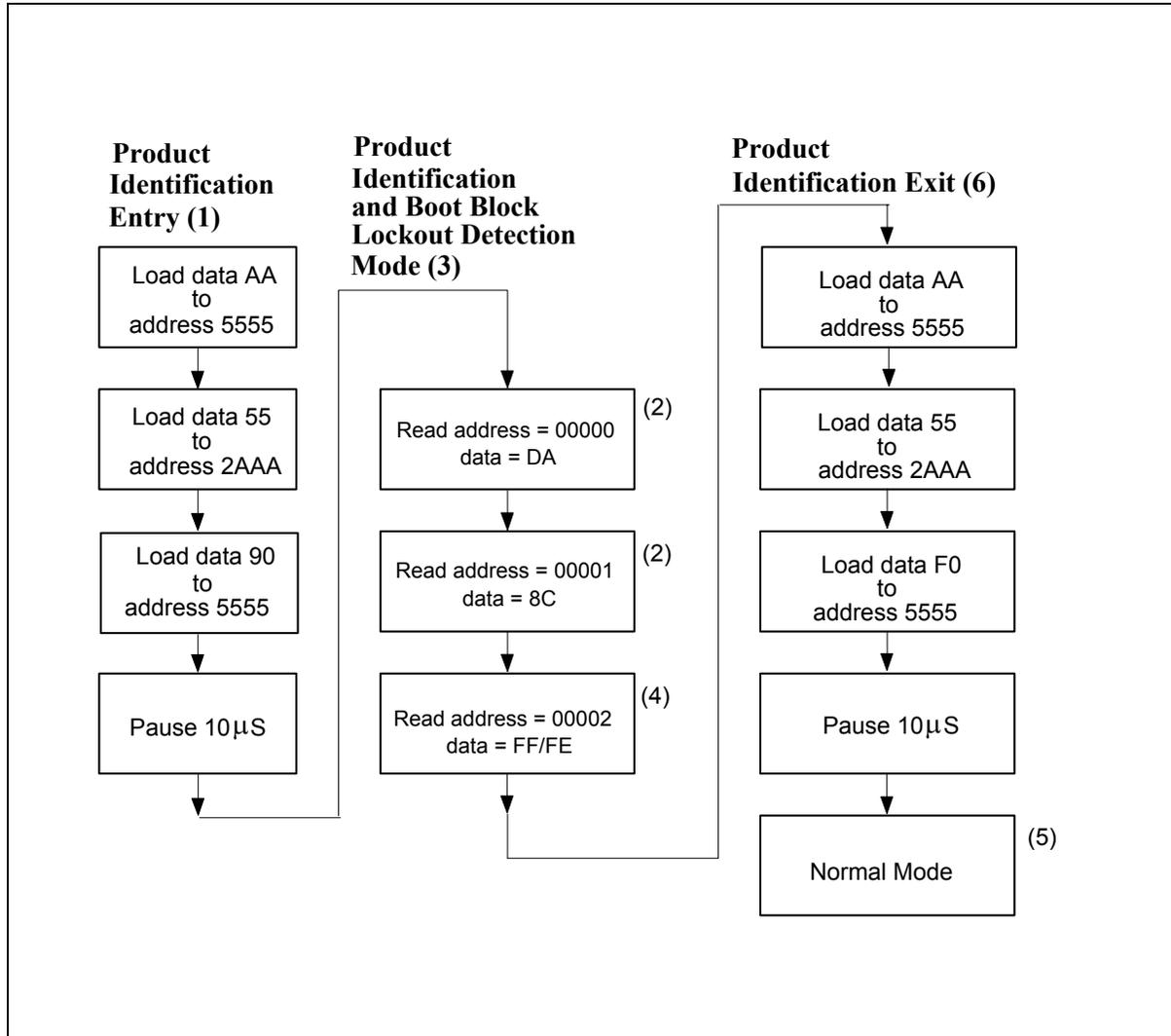
Embedded #Data Polling Algorithm



Embedded Toggle Bit Algorithm

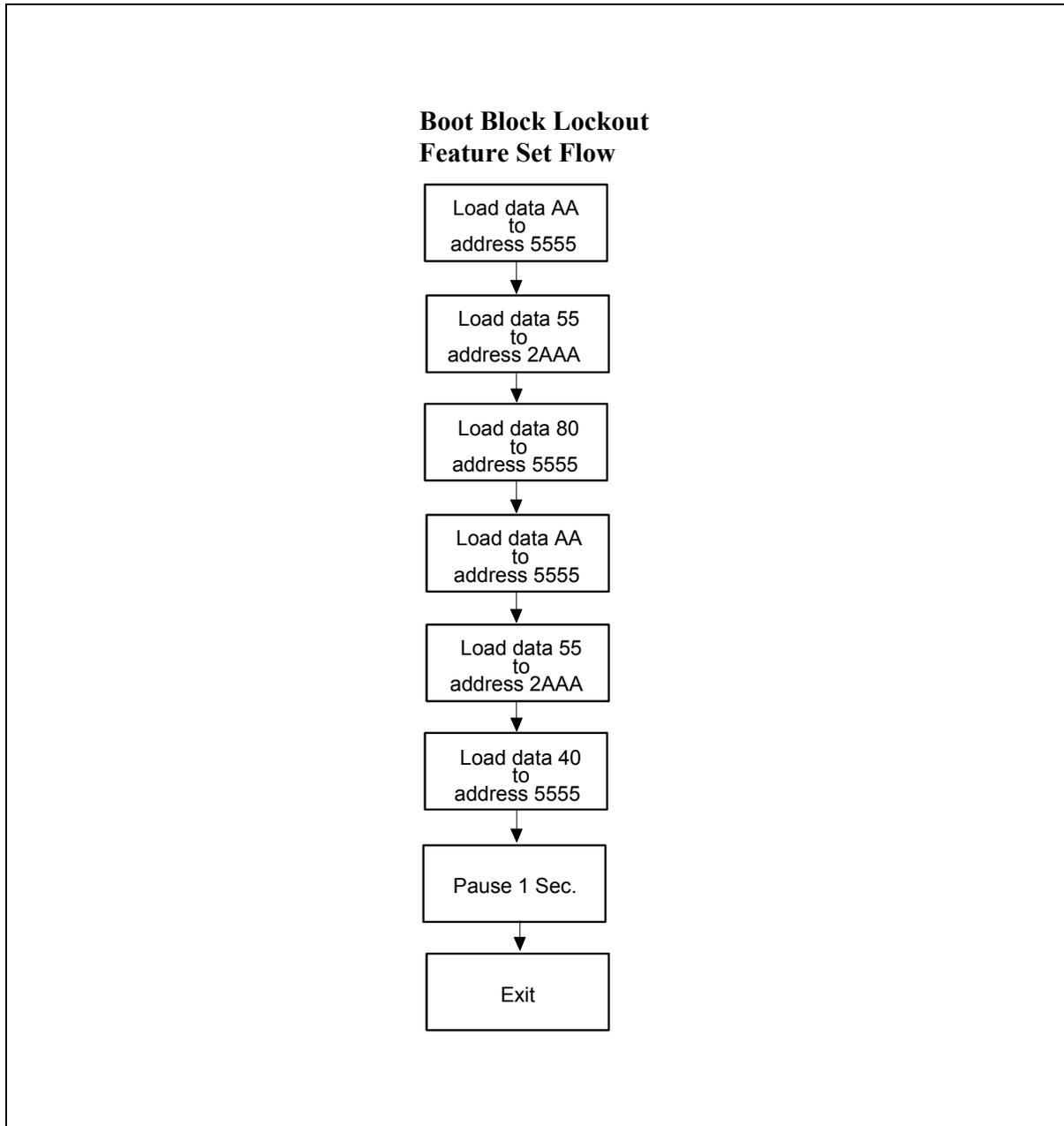


Software Product Identification and Boot Block Lockout Detection Acquisition Flow



Notes for software product identification/boot block lockout detection:

- (1) Data Format: DQ15-DQ8 (Don't Care), DQ7 – DQ0 (Hex); Address Format: A14 – A0 (Hex)
- (2) A1 – A15 = V_{IL}; manufacture code is read for A0 = V_{IL}; device code is read for A0 = V_{IH}.
- (3) The device does not remain in identification and boot block lockout detection mode if power down.
- (4) If the output data is "FF Hex," the boot block programming lockout feature is activated; if the output data "FE Hex," the lockout feature is inactivated and the block can be programmed.
- (5) The device returns to standard operation mode.
- (6) Optional 1-write cycle (write F0 hex at XXXX address) can be used to exit the product identification/boot block lockout detection.

Boot Block Lockout Enable Acquisition Flow

Notes for boot block lockout enable:

Data Format: DQ7 – DQ0 (Hex)

Address Format: A14 – A0 (Hex)



7. ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings

PARAMETER	RATING	UNIT
Power Supply Voltage to Vss Potential	-0.5 to +7.0	V
Operating Temperature	0 to +70	°C
Storage Temperature	-65 to +150	°C
D.C. Voltage on Any Pin to Ground Potential except #OE	-0.5 to VDD +1.0	V
Transient Voltage (<20 nS) on Any Pin to Ground Potential	-1.0 to VDD +1.0	V
Voltage on #OE Pin to Ground Potential	-0.5 to 12.5	V

Note: Exposure to conditions beyond those listed under Absolute Maximum Ratings may adversely affect the life and reliability of the device.

DC Operating Characteristics

(VDD = 5.0V ±10%, VSS = 0V, TA = 0 to 70° C)

PARAMETER	SYM.	TEST CONDITIONS	LIMITS			UNIT
			MIN.	TYP.	MAX.	
Power Supply Current	ICC	#CE = #OE = VIL, #WE = VIH, all DQs open Address inputs = VIL/VIH, at f = 5 MHz	-	25	50	mA
Standby VDD Current (TTL input)	ISB1	#CE = VIH, all DQs open Other inputs = VIL/VIH	-	2	3	mA
Standby VDD Current (CMOS input)	ISB2	#CE = VDD -0.3V, all DQs open Other inputs = VDD -0.3V/ VSS	-	20	100	μA
Input Leakage Current	ILI	VIN = VSS to VDD	-	-	10	μA
Output Leakage Current	ILO	VOUT = VSS to VDD	-	-	10	μA
Input Low Voltage	VIL	-	-0.3	-	0.8	V
Input High Voltage	VIH	-	2.0	-	VDD +0.5	V
Output Low Voltage	VOL	IOL = 2.1 mA	-	-	0.45	V
Output High Voltage	VOH	IOH = -0.4 mA	2.4	-	-	V



Power-up Timing

PARAMETER	SYMBOL	TYPICAL	UNIT
Power-up to Read Operation	TPU. READ	100	μS
Power-up to Write Operation	TPU. WRITE	5	mS

Capacitance

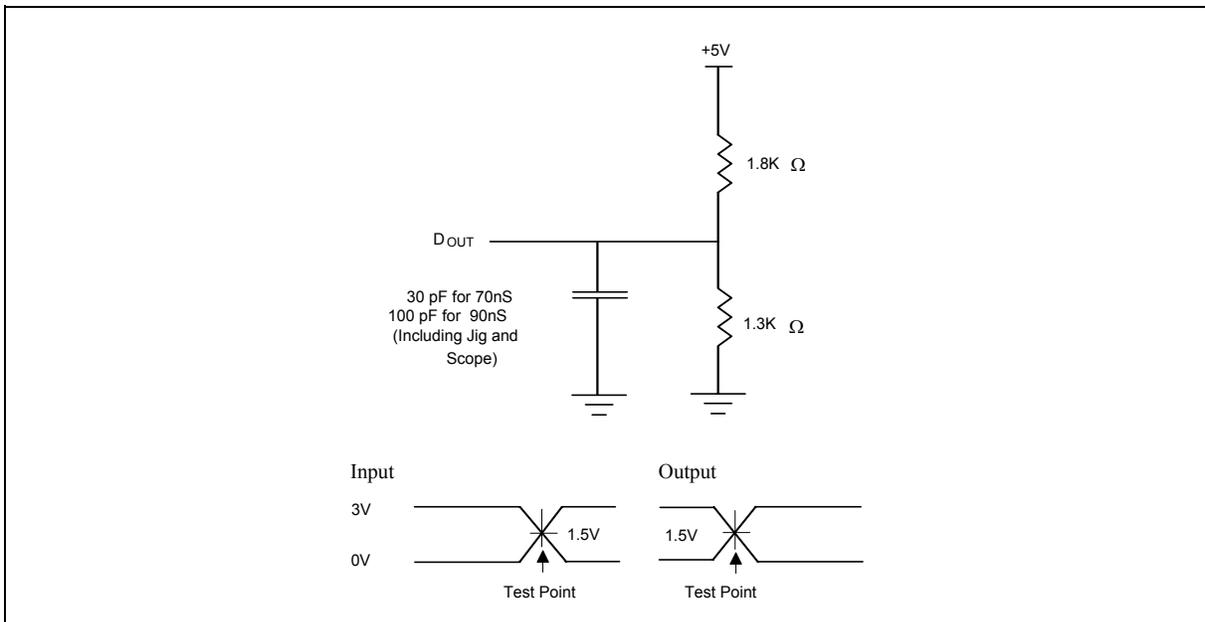
(V_{DD} = 5.0V, T_A = 25° C, f = 1 MHz)

PARAMETER	SYMBOL	CONDITIONS	MAX.	UNIT
I/O Pin Capacitance	C _{I/O}	V _{I/O} = 0V	12	pF
Input Capacitance	C _{IN}	V _{IN} = 0V	6	pF

AC Test Conditions

PARAMETER	CONDITIONS
Input Pulse Levels	0V to 3.0V
Input Rise/Fall Time	< 5 nS
Input/Output Timing Level	1.5V/1.5V
Output Load	1 TTL Gate and C _L = 100 pF for 90 nS C _L = 30 pF for 70 nS

AC Test Load and Waveform





Read Cycle Timing Parameters

(V_{DD} = 5.0V ±10%, V_{DD} = 0V, T_A = 0 to 70° C)

PARAMETER	SYM.	W49F020-70		W49F020-90		UNIT
		MIN.	MAX.	MIN.	MAX.	
Read Cycle Time	TRC	70	-	90	-	nS
Chip Enable Access Time	TCE	-	70	-	90	nS
Address Access Time	TAA	-	70	-	90	nS
Output Enable Access Time	TOE	-	35	-	40	nS
#CE Low to Active Output	TCLZ	0	-	0	-	nS
#OE Low to Active Output	TOLZ	0	-	0	-	nS
#CE High to High-Z Output	TCHZ	-	25	-	25	nS
#OE High to High-Z Output	TOHZ	-	25	-	25	nS
Output Hold from Address Change	TOH	0	-	0	-	nS

Write Cycle Timing Parameters

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Address Setup Time	TAS	0	-	-	nS
Address Hold Time	TAH	50	-	-	nS
#WE and #CE Setup Time	TCS	0	-	-	nS
#WE and #CE Hold Time	TCH	0	-	-	nS
#OE High Setup Time	TOES	0	-	-	nS
#OE High Hold Time	TOEH	0	-	-	nS
#CE Pulse Width	TCP	100	-	-	nS
#WE Pulse Width	TWP	100	-	-	nS
#WE High Width	TWPH	100	-	-	nS
Data Setup Time	TDS	50	-	-	nS
Data Hold Time	TDH	0	-	-	nS
Byte programming Time	TBP	-	10	50	μS
Erase Cycle Time	TEC	-	0.1	1	S

Note: All AC timing signals observe the following guidelines for determining setup and hold times:

(a) High level signal's reference level is V_{IH} and (b) low level signal's reference level is V_{IL}.



Data Polling and Toggle Bit Timing Parameters

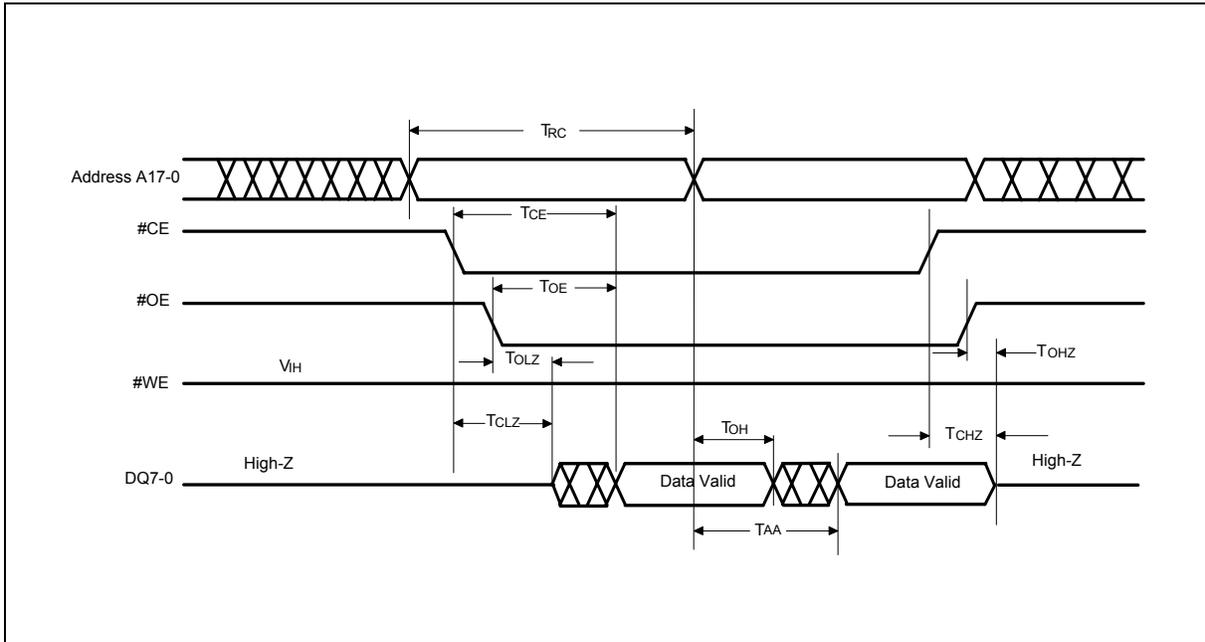
PARAMETER	SYMBOL	W49F020-70		W49F020-90		UNIT
		MIN.	MAX.	MIN.	MAX.	
#OE to Data Polling Output Delay	TOEP	-	35	-	40	nS
#CE to Data Polling Output Delay	TCEP	-	70	-	90	nS
#OE to Toggle Bit Output Delay	TOET	-	35	-	40	nS
#CE to Toggle Bit Output Delay	TCET	-	70	-	90	nS

Reset Timing Parameters

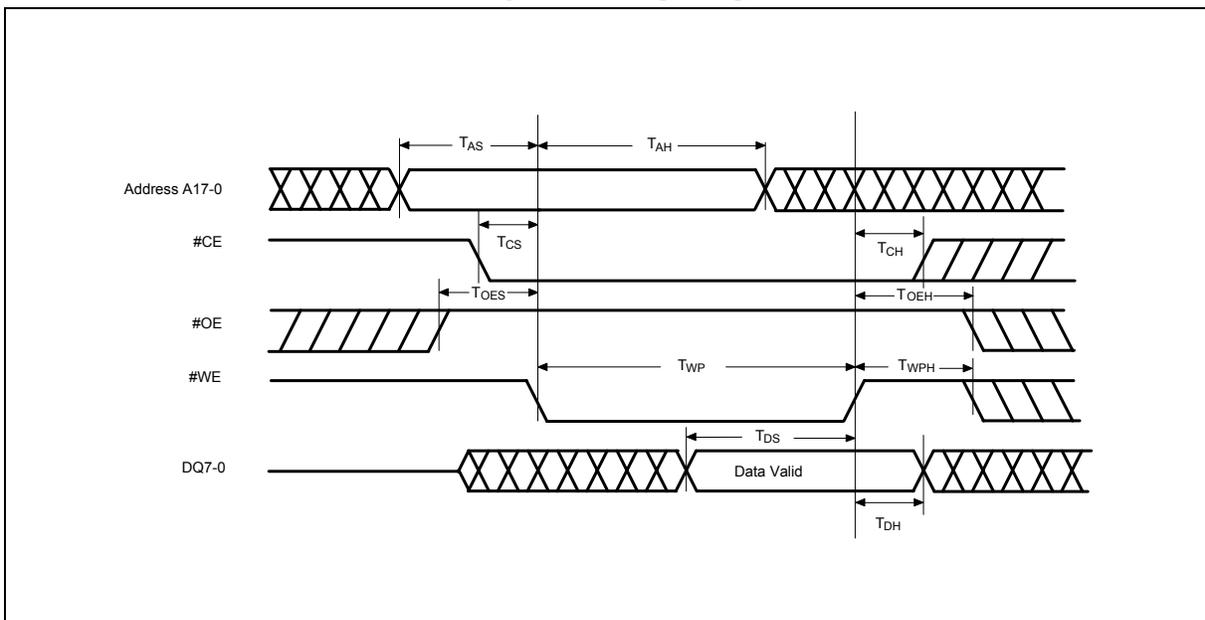
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
V _{DD} stable to Reset Active	T _{PRST}	1	-	-	mS
Reset Pulse Width	T _{RSTP}	500	-	-	nS
Reset Active to Output Float	T _{RSTF}	-	-	50	nS
Reset Inactive to Input Active	T _{RST}	1	-	-	μS

9. TIMING WAVEFORMS

Read Cycle Timing Diagram

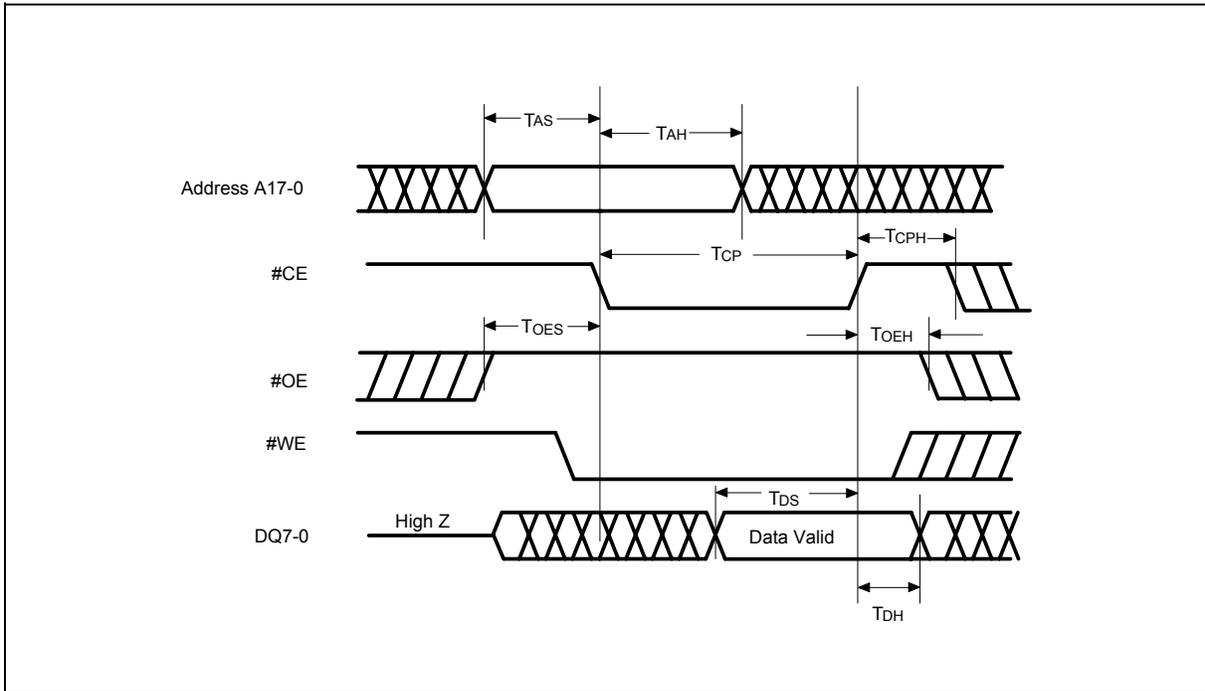


#WE Controlled Command Write Cycle Timing Diagram

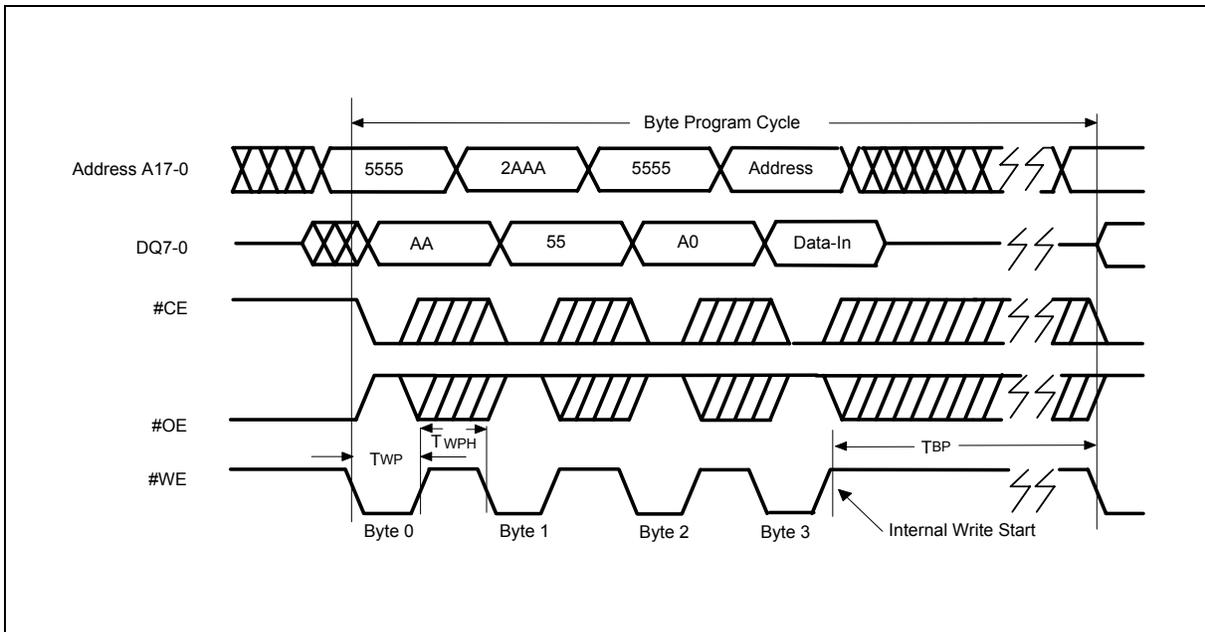


Timing Waveforms, continued

#CE Controlled Command Write Cycle Timing Diagram



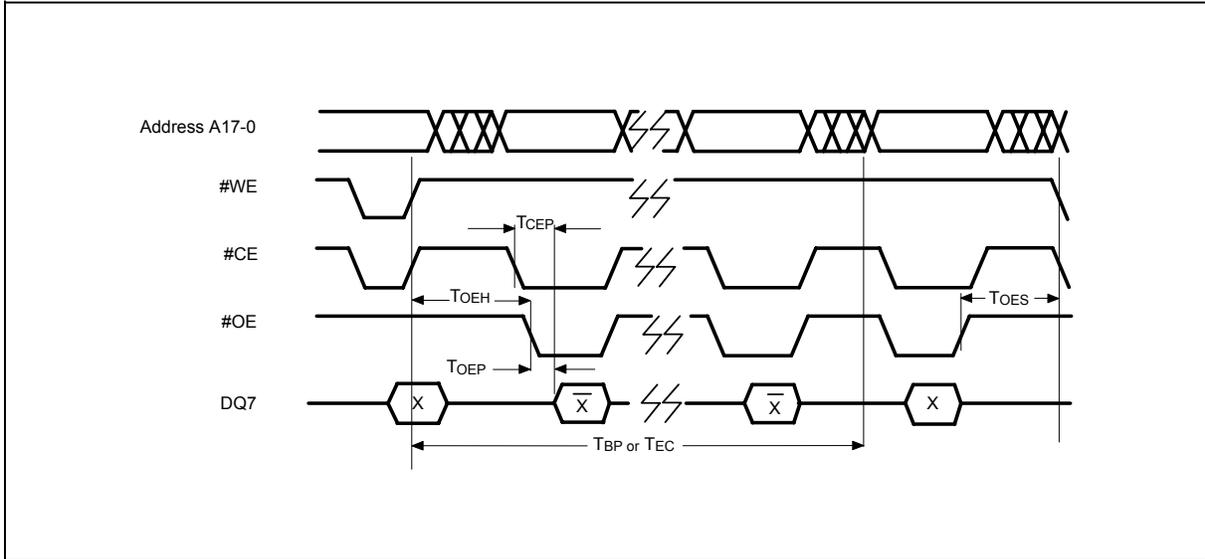
Program Cycle Timing Diagram



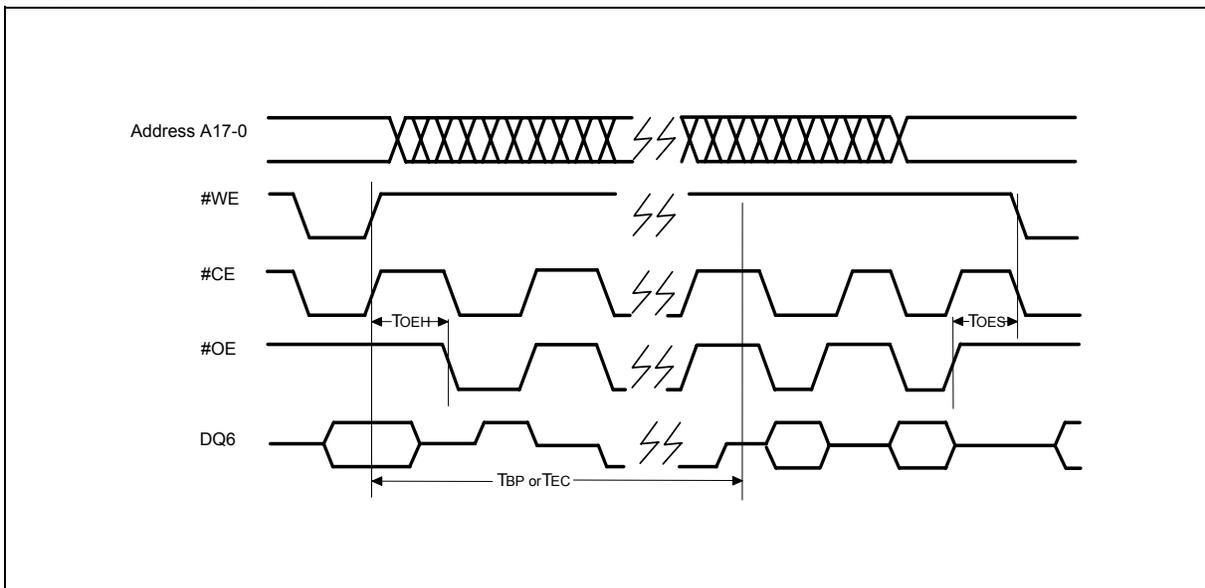


Timing Waveforms, continued

#DATA Polling Timing Diagram



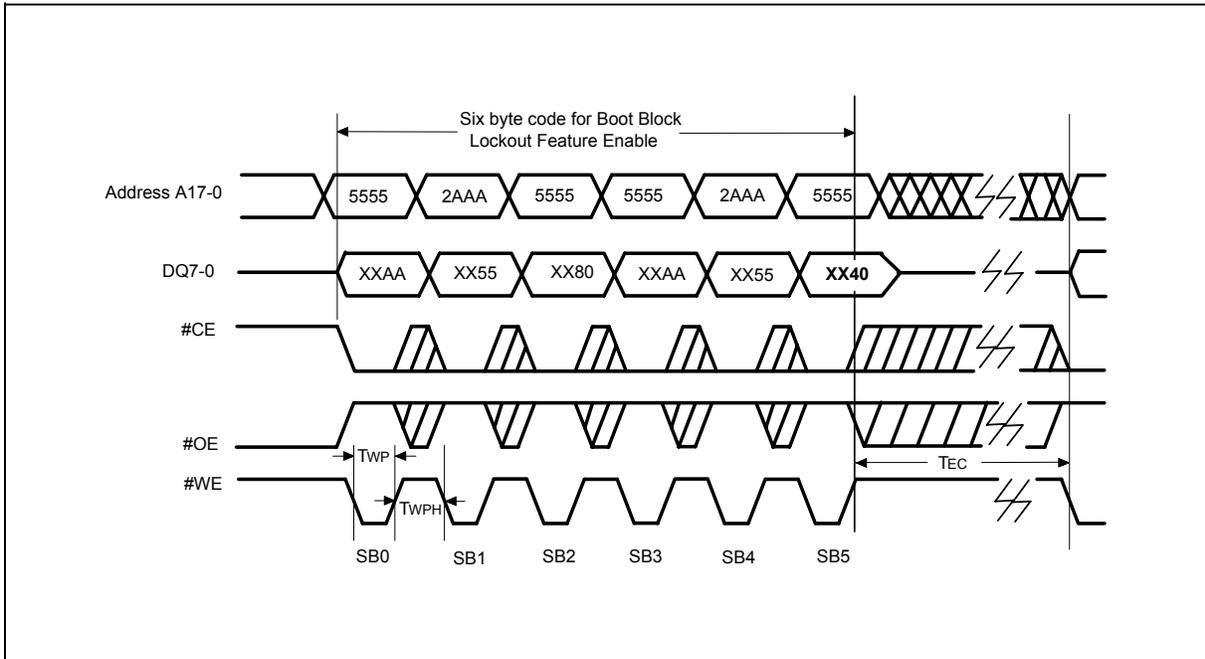
Toggle Bit Timing Diagram



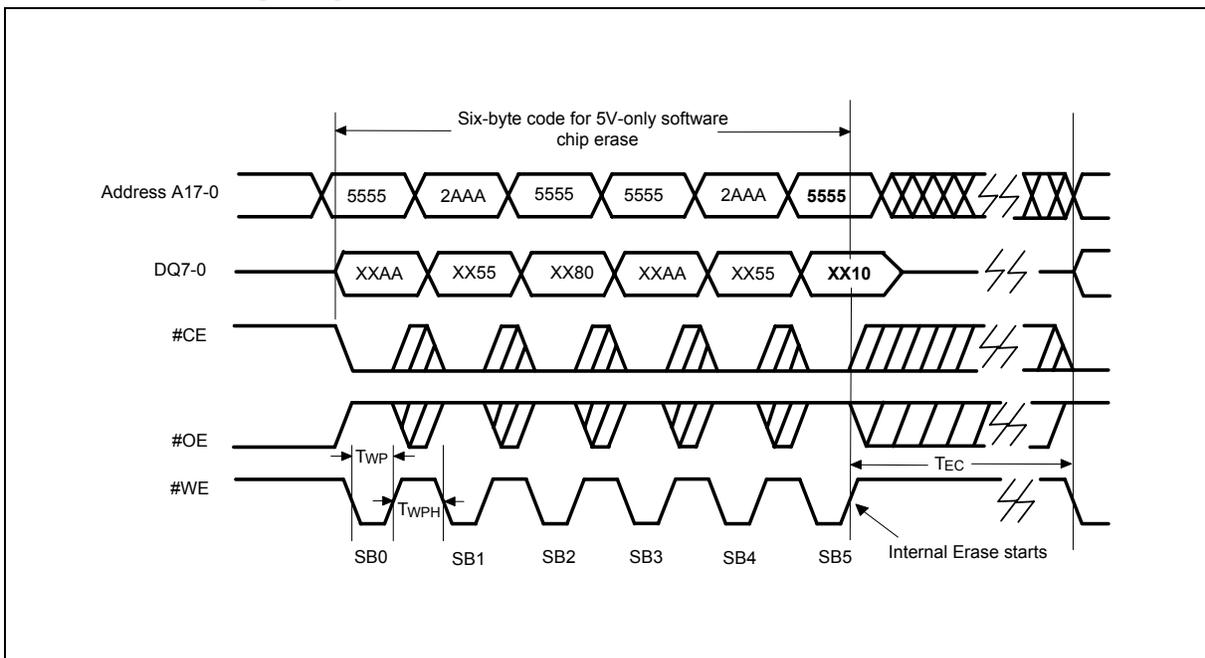


Timing Waveforms, continued

Boot Block Lockout Enable Timing Diagram



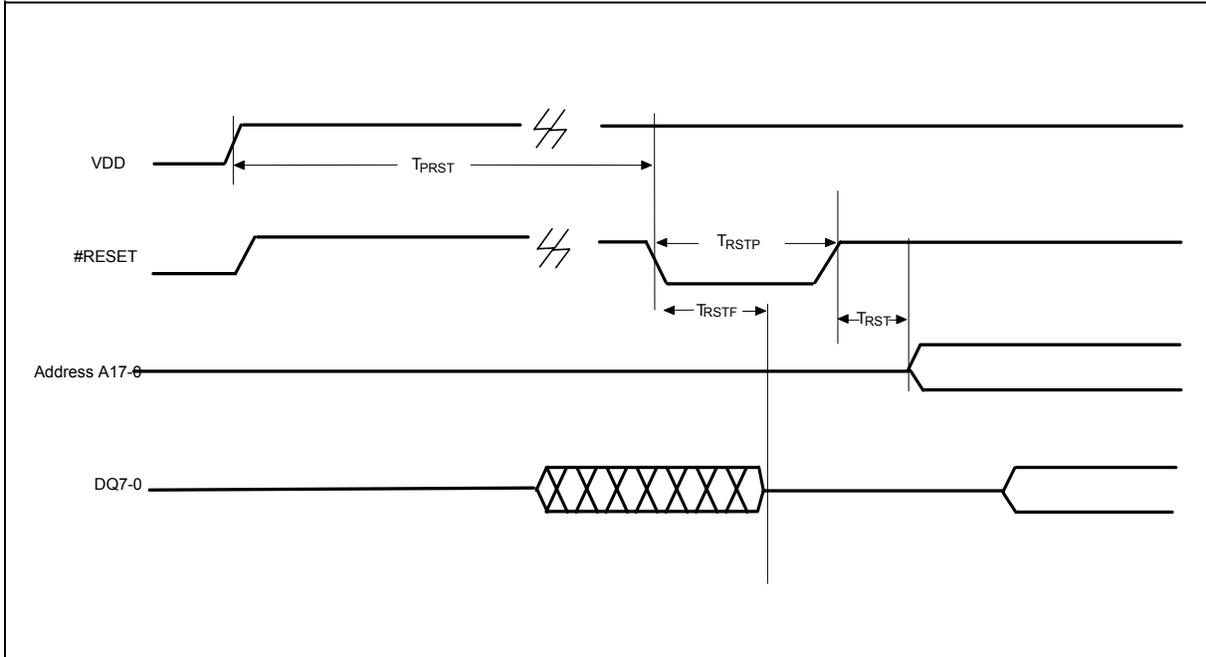
Chip Erase Timing Diagram





Timing Waveforms, continued

Reset Timing Diagram





10. ORDERING INFORMATION

PART NO.	ACCESS TIME (nS)	POWER SUPPLY CURRENT MAX. (mA)	STANDBY V _{DD} CURRENT MAX. (μA)	PACKAGE	CYCLE
W49F020-90B	90	50	100 (CMOS)	32-pin DIP	10K
W49F020T-70B	70	50	100 (CMOS)	32-pin TSOP (8 mm × 20 mm)	10K
W49F020T-90B	90	50	100 (CMOS)	32-pin TSOP (8 mm × 20 mm)	10K
W49F020P-70B	70	50	100 (CMOS)	32-pin PLCC	10K
W49F020P-90B	90	50	100 (CMOS)	32-pin PLCC	10K

Notes:

1. Winbond reserves the right to make changes to its products without prior notice.
2. Purchasers are responsible for performing appropriate quality assurance testing on products intended for use in applications where personal injury might occur as a consequence of product failure.
3. The part number shown in the Ordering Information table is only for Bottom Boot Block part, which is in the lower address range. For the requirement of the higher address range boot block, the Top Boot Block, please contact Winbond FAE for details.

11. HOW TO READ THE TOP MARKING

Example: The top marking of 32-pin PLCC W49F020P-90B



1st line: winbond logo

2nd line: the part number: W49F020P-90B

3rd line: the lot number

4th line: the tracking code: 149 O B SA

149: Packages made in '01, week 49

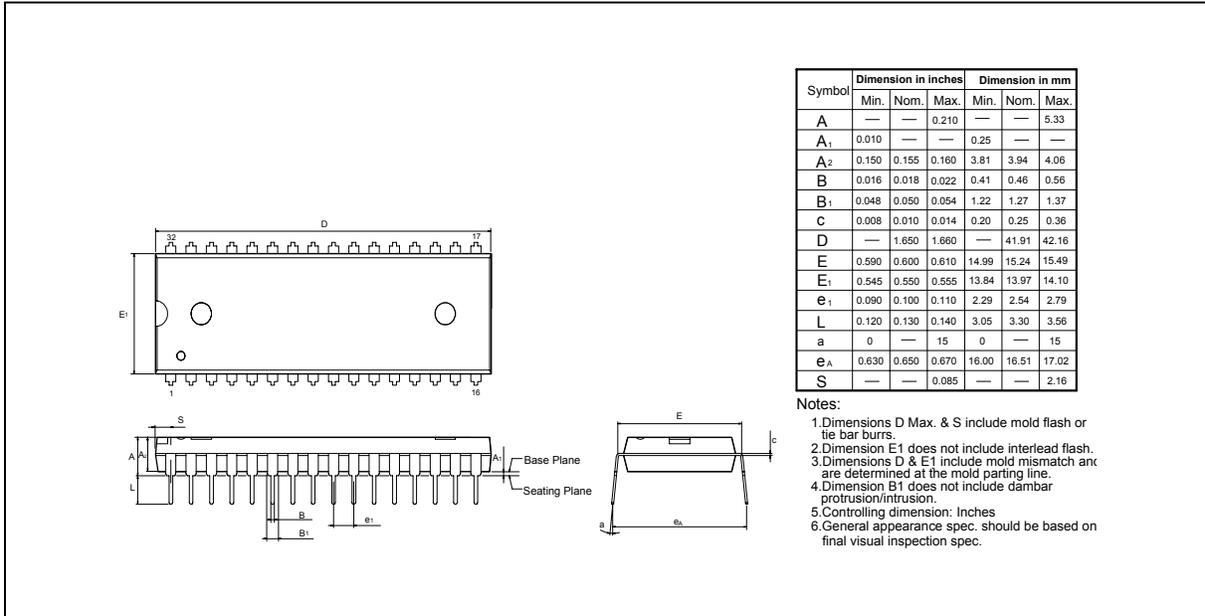
O: Assembly house ID: A means ASE, O means OSE, ...etc.

B: IC revision; A means version A, B means version B, ...etc.

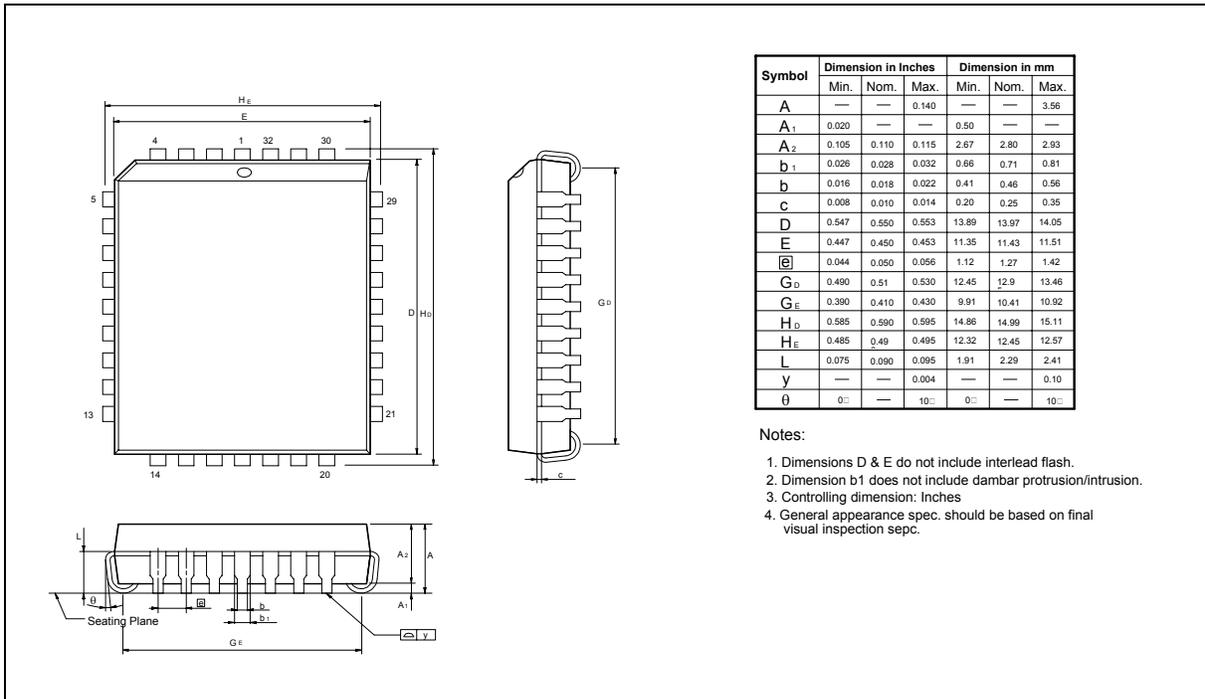
SA: Process code

12. PACKAGE DIMENSIONS

32-pin P-DIP

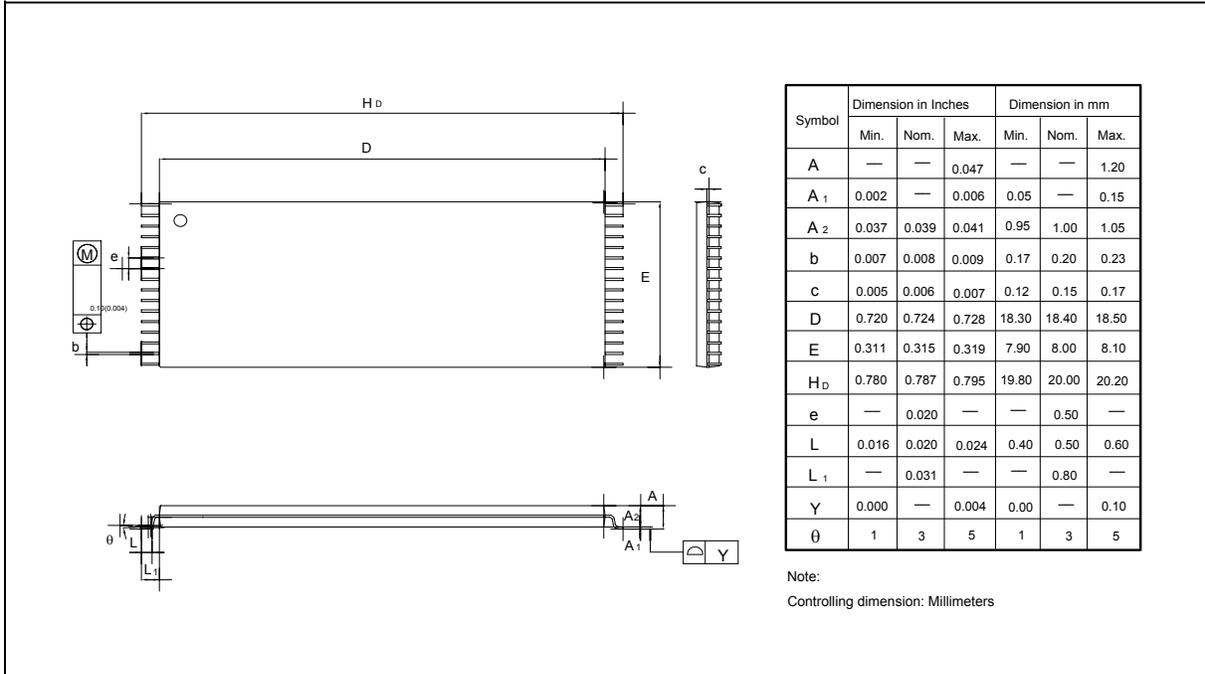


32-pin PLCC



Package Dimensions, continued

32-pin TSOP





13. VERSION HISTORY

VERSION	DATE	PAGE	DESCRIPTION
A1	Oct. 1999	-	Initial Issued
A2	Dec. 18, 2002	1, 21	Delete 1K endurance
		21	Change W49F020Q 70/90 to W49F020T-70/90
		4	Modify the description of VDD Power Up/Down Detection in Hardware Data Protection
		6-10	Delete old flow chart and add embedded algorithm
		21	Correct Part. No for ordering information
			Delete Part. No of W49F020-70B for ordering information
		21	Add HOW TO READ THE TOP MARKING
	2, 3, 14, 19	Add in #RESET function	
A3	Feb. 21, 2003	7	Correct Embedded Erase Algorithm (Delete Main-memory Erase Command Sequence)
		8	Correct VA(Valid Address) definition in Embedded #Data Polling Algorithm



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